

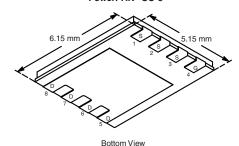


Vishay Siliconix

N-Channel 100 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^a Q _g (7			
100	0.0305 at V _{GS} = 10 V	22			
	0.033 at V _{GS} = 7.5 V	21	9.5 nC		
	0.043 at V _{GS} = 4.5 V	18.5			

PowerPAK® SO-8



Ordering Information: Si7454CDP-T1-GE3 (Lead (Pb)-free and Halogen-free)

FEATURES

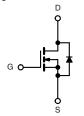
- Halogen-free According to IEC 61249-2-21
- TrenchFET® Power MOSFET
- 100 % R_g Tested 100 % UIS Tested
- Compliant to RoHS Directive 2002/95/EC



COMPLIANT **HALOGEN FREE**

APPLICATIONS

- DC/DC Primary Side Switch
- Telecom/Server 48 V, Full/Half-Bridge dc-to-dc
- Industrial



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	T _A = 25 °C, unles	ss otherwise note	ed	
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	100	V	
Gate-Source Voltage		V _{GS}	± 20	v
	T _C = 25 °C		22	
Continuous Proin Current (T = 150 °C)	T _C = 70 °C		17.6	
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	8.1 ^{b, c}	
	T _A = 70 °C		6.5 ^{b, c}	
Pulsed Drain Current		I _{DM}	40	Α
Continuous Course Prais Diada Current	T _C = 25 °C	_	22	
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	3.7 ^{b, c}	
Single Pulse Avalanche Current	1 0.1 ml l	I _{AS}	15	
Single Pulse Avalanche Energy L = 0.1 mH		E _{AS}	11.2	mJ
	T _C = 25 °C		29.7	
Maximum Power Dissipation	T _C = 70 °C	ь	19	10/
	T _A = 25 °C	P _D	4.1 ^{b, c}	W
	T _A = 70 °C		2.6 ^{b, c}	
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 150	00	
Soldering Recommendations (Peak Temperature) ^{d, e}			260	- °C

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 10 s	R_{thJA}	24	30	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	3.3	4.2]	

Notes:

- a. Based on $T_C = 25$ °C.
- b. Surface mounted on 1" x 1" FR4 board.
- d. See solder profile (www.vishay.com/ppg?73257). The PowerPAK SO-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 70 °C/W.

Si7454CDP

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static						L	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	100			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050A		47		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	$I_D = 250 \mu A$		- 5.4			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.2		2.8	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zana Onto Waller on Brain Ourse i		V _{DS} = 100 V, V _{GS} = 0 V			1	μА	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 100 V, V _{GS} = 0 V, T _J = 55 °C			10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	20			Α	
		V _{GS} = 10 V, I _D = 10 A		0.0252	0.0305	†	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 7.5 \text{ V}, I_D = 8 \text{ A}$		0.027	0.033	Ω	
	1	$V_{GS} = 4.5 \text{ V}, I_D = 6 \text{ A}$		0.0345	0.043		
Forward Transconductance ^a	9 _{fs}	V _{DS} = 10 V, I _D = 10 A		20		S	
Dynamic ^b			1		1	<u> </u>	
Input Capacitance				580			
Output Capacitance	C _{oss}	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		347		pF	
Reverse Transfer Capacitance	C _{rss}			24			
'	.55	V _{DS} = 50 V, V _{GS} = 10 V, I _D = 10 A		12.8	2.8 19.5		
Total Gate Charge	Qg	V _{DS} = 50 V, V _{GS} = 7.5 V, I _D = 10 A		9.8	15		
-		<u> </u>		6.3	9.5	nC	
Gate-Source Charge	Q_{qs}	$V_{DS} = 50 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$		1.8			
Gate-Drain Charge	Q _{gd}			2.9			
Gate Resistance	R _g	f = 1 MHz	0.8	3.8	7.6	Ω	
Turn-On Delay Time	t _{d(on)}			8	16		
Rise Time	t _r	$V_{DD} = 50 \text{ V}, R_L = 5 \Omega$		12	24	- ns	
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ 10 A, V_{GEN} = 10 V, R_g = 1 Ω		16	32		
Fall Time	t _f			10	20		
Turn-On Delay Time	t _{d(on)}			10	20		
Rise Time	t _r	$V_{DD} = 50 \text{ V}, R_L = 5 \Omega$		12	24		
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ 10 A, V_{GEN} = 7.5 V, R_g = 1 Ω		17	34		
Fall Time	t _f			10	20		
Drain-Source Body Diode Characteristic	s		•	'	•		
Continuous Source-Drain Diode Current	I _S	$T_C = 25 ^{\circ}C$			22	Λ	
Pulse Diode Forward Current ^a	I _{SM}				40	A	
Body Diode Voltage	V_{SD}	I _S = 4 A		0.78	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			31	62	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	L _ E A dl/dt _ 100 A/va T _ 05 °C		28	56	nC	
Reverse Recovery Fall Time	t _a	$I_F = 5 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		15			
Reverse Recovery Rise Time	t _b			16	İ	ns	

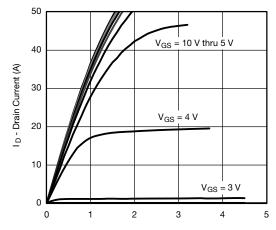
- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



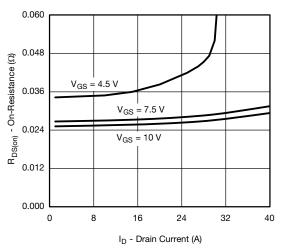
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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

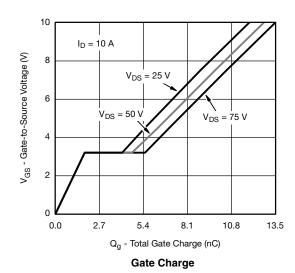


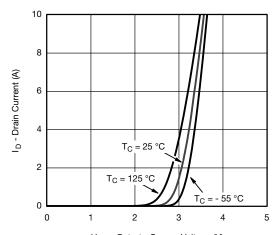
 V_{DS} - Drain-to-Source Voltage (V)

Output Characteristics

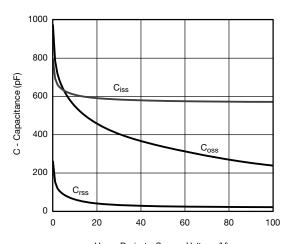


On-Resistance vs. Drain Current and Gate Voltage



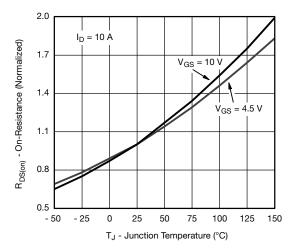


V_{GS} - Gate-to-Source Voltage (V) **Transfer Characteristics**



V_{DS} - Drain-to-Source Voltage (V)



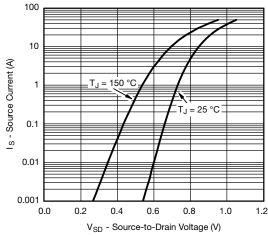


On-Resistance vs. Junction Temperature

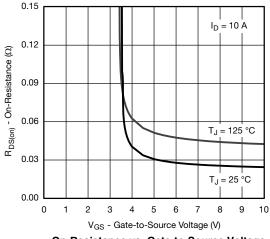
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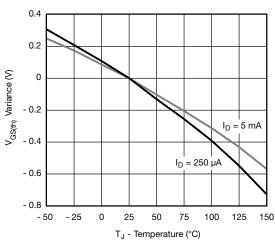
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



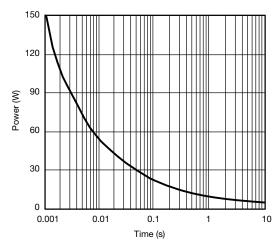
Source-Drain Diode Forward Voltage



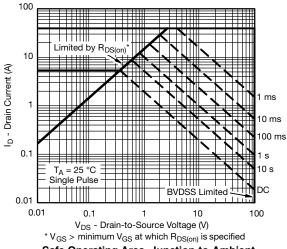
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



Single Pulse Power, Junction-to-Ambient

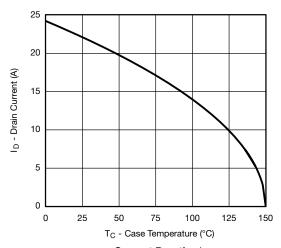


Safe Operating Area, Junction-to-Ambient

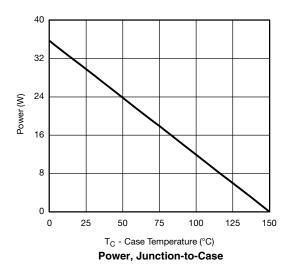


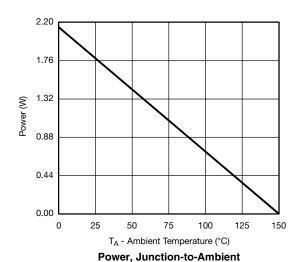
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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating*





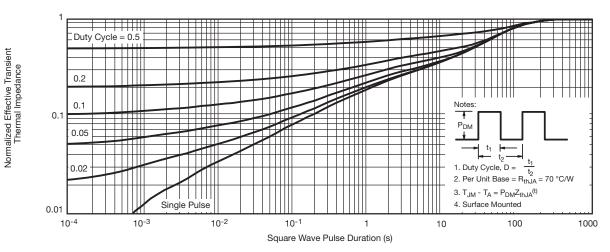
^{*} The power dissipation PD is based on TJ(max) = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

Si7454CDP

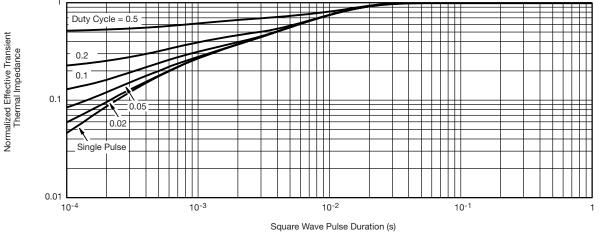
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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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